



<b>Search Notes</b>  	Application/Control No.  10687286	Applicant(s)/Patent Under Reexamination  BESTGEN ET AL.
	Examiner Lewis, Cheryl	Art Unit 2167


Notes	Date	Examiner
searched WEST US Patents, JPO Abstracts, EPO Abstracts, Derwent Patents, IBM Disclosure, and PLUS search	9/29/06	CL
searched IEEE Xplore database and ACM Digital Library	9/29/06	CL

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<b>Interference Searched</b>  	Application/Control No.  10687286	Applicant(s)/Patent Under Reexamination  BESTGEN ET AL.
	Examiner Lewis, Cheryl	Art Unit 2167

Class	SubClass	Date	Examiner
same as	above	9/29/06	CL

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	<p>Examiner</p> <p>Lewis, Cheryl</p>	<p>Art Unit</p> <p>2167</p>

Class	SubClass	Date	Examiner
707	2-6 and 100	9/29/06	CL

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